# **MOSFET** – Power, Single, N-Channel, SO-8 FL 30 V, 246 A

# Features

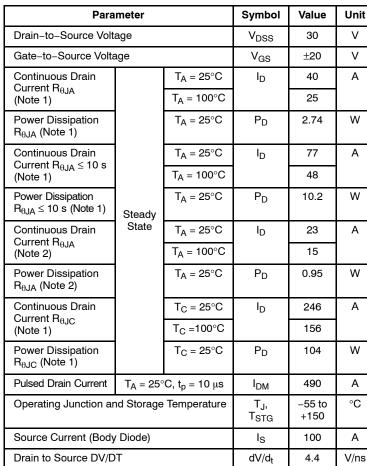
- Low R<sub>DS(on)</sub> to Improve Conduction and Overall Efficiency
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### Applications

- OR-ing FET, Power Load Switch, Motor Control
- Refer to Application Note AND8195/D for Mounting Information

### **End Products**

• Motor Control, UPS, Fault-Tolerant Power Systems, Hot Swap



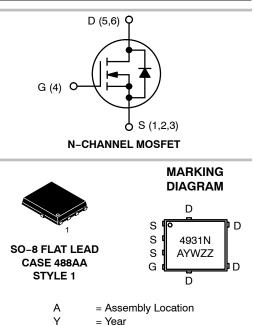
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)



# **ON Semiconductor®**

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	1.1 mΩ @ 10 V	246 A
50 V	1.5 mΩ @ 4.5 V	240 A



#### **ORDERING INFORMATION**

= Work Week

= Lot Traceability

w

77

Device	Package	Shipping <sup>†</sup>
NTMFS4931NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4931NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 41 A <sub>pk</sub> , L = 0.3 mH, R <sub>G</sub> = 25 $\Omega$ )	E <sub>AS</sub>	252	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Surface-mounted on FR4 board using the minimum recommended pad size.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.2	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	45.7	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	132	°C/W
Junction-to-Ambient – (t $\leq$ 10 s) (Note 3)	$R_{ hetaJA}$	12.3	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				18		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			15	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)						-	-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS}$ = $V_{DS}$ , $I_D$ = 250 $\mu$ A		1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	R <sub>DS(on)</sub> V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		0.85	1.1	
			I <sub>D</sub> = 15 A		0.82		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		1.2	1.5	mΩ
			I <sub>D</sub> = 15 A		1.2		
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			86		S

Input Capacitance	C <sub>ISS</sub>		9821	
Output Capacitance	C <sub>OSS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 15 V	2720	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>		234	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A	61.5	
Threshold Gate Charge	Q <sub>G(TH)</sub>		14.2	nC
Gate-to-Source Charge	Q <sub>GS</sub>	$v_{GS} = 4.5 v, v_{DS} = 15 v; i_D = 30 A$	25.2	nc
Gate-to-Drain Charge	Q <sub>GD</sub>		15.9	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_D$ = 30 A	128	nC

#### SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		27	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	29	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D}$ = 15 A, R <sub>G</sub> = 3.0 $\Omega$	36	ns
Fall Time	t <sub>f</sub>		24	

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

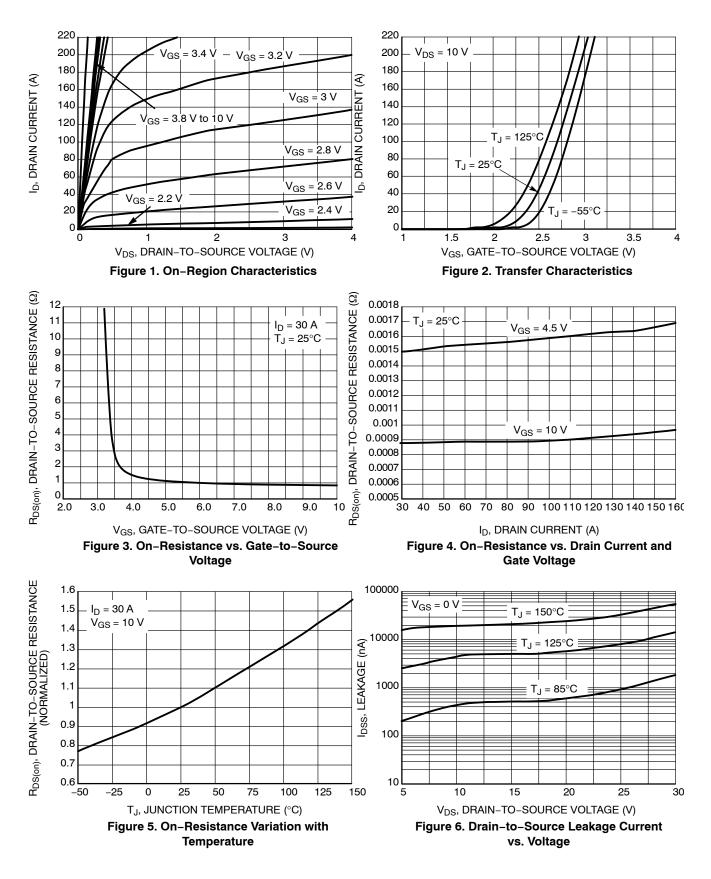
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 $\Omega$			15		_
Rise Time	t <sub>r</sub>				17		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D} = 15 \rm A,  R_{\rm C}$	<sub>a</sub> = 3.0 Ω		80		ns ns
Fall Time	t <sub>f</sub>				22		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	SD $V_{GS} = 0 V$ , $T_J = 25^{\circ}C$ $I_S = 30 A$ $T_J = 125^{\circ}C$		0.8	1.0	v	
			T <sub>J</sub> = 125°C		0.62		v
Reverse Recovery Time	t <sub>RR</sub>				64		
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/d	t = 100 A/μs,		33		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = 30 A			31		
Reverse Recovery Charge	Q <sub>RR</sub>				100		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.50		nH
Drain Inductance	L <sub>D</sub>	− T <sub>A</sub> = 25°C			0.005		nH
Gate Inductance	L <sub>G</sub>				1.84		nH
Gate Resistance	R <sub>G</sub>				0.7	1.8	Ω

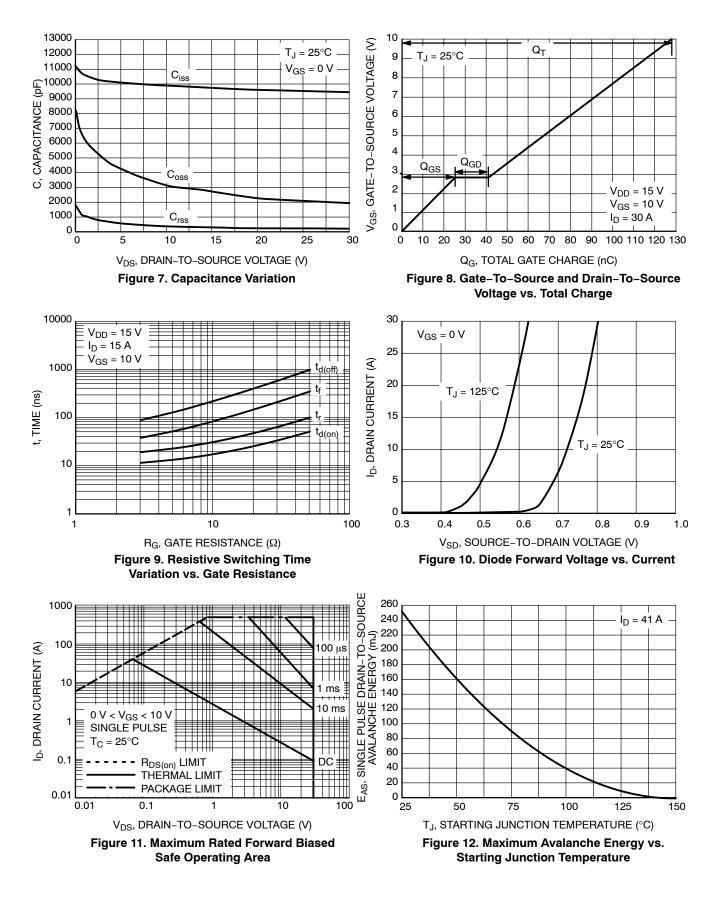
5. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **TYPICAL CHARACTERISTICS**



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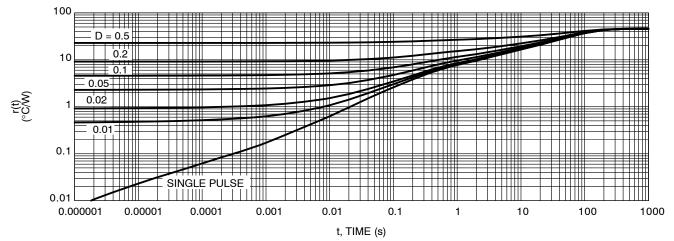
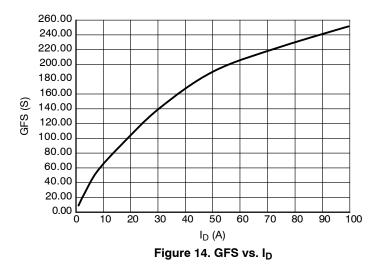


Figure 13. Thermal Response







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